

# 74HC193; 74HCT193

## Presettable synchronous 4-bit binary up/down counter

Rev. 4 — 24 June 2013

Product data sheet

### 1. General description

The 74HC193; 74HCT193 is a 4-bit synchronous binary up/down counter. Separate up/down clocks, CPU and CPD respectively, simplify operation. The outputs change state synchronously with the LOW-to-HIGH transition of either clock input. If the CPU clock is pulsed while CPD is held HIGH, the device will count up. If the CPD clock is pulsed while CPU is held HIGH, the device will count down. Only one clock input can be held HIGH at any time to guarantee predictable behaviour. The device can be cleared at any time by the asynchronous master reset input ( $\overline{\text{MR}}$ ); it may also be loaded in parallel by activating the asynchronous parallel load input ( $\overline{\text{PL}}$ ). The terminal count up ( $\overline{\text{TCU}}$ ) and terminal count down ( $\overline{\text{TCD}}$ ) outputs are normally HIGH. When the circuit has reached the maximum count state of 15, the next HIGH-to-LOW transition of CPU will cause  $\overline{\text{TCU}}$  to go LOW.  $\overline{\text{TCU}}$  will stay LOW until CPU goes HIGH again, duplicating the count up clock. Likewise, the  $\overline{\text{TCD}}$  output will go LOW when the circuit is in the zero state and the CPD goes LOW. The terminal count outputs can be used as the clock input signals to the next higher order circuit in a multistage counter, since they duplicate the clock waveforms. Multistage counters will not be fully synchronous, since there is a slight delay time difference added for each stage that is added. The counter may be preset by the asynchronous parallel load capability of the circuit. Information present on the parallel data inputs (D0 to D3) is loaded into the counter and appears on the outputs (Q0 to Q3) regardless of the conditions of the clock inputs when the parallel load ( $\overline{\text{PL}}$ ) input is LOW. A HIGH level on the master reset ( $\overline{\text{MR}}$ ) input will disable the parallel load gates, override both clock inputs and set all outputs (Q0 to Q3) LOW. If one of the clock inputs is LOW during and after a reset or load operation, the next LOW-to-HIGH transition of that clock will be interpreted as a legitimate signal and will be counted. Inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess of  $V_{\text{CC}}$ .

### 2. Features and benefits

- Input levels:
  - ◆ For 74HC193: CMOS level
  - ◆ For 74HCT193: TTL level
- Synchronous reversible 4-bit binary counting
- Asynchronous parallel load
- Asynchronous reset
- Expandable without external logic
- Complies with JEDEC standard no. 7A
- ESD protection:
  - ◆ HBM JESD22-A114F exceeds 2000 V
  - ◆ MM JESD22-A115-A exceeds 200 V.



- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C.

3. Ordering information

Table 1. Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
74HC193D	-40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1
74HC193DB	-40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads; body width 5.3 mm	SOT338-1
74HC193N	-40 °C to +125 °C	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4
74HC193PW	-40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1
74HCT193D	-40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1
74HCT193DB	-40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads; body width 5.3 mm	SOT338-1
74HCT193N	-40 °C to +125 °C	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4
74HCT193PW	-40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1

4. Functional diagram

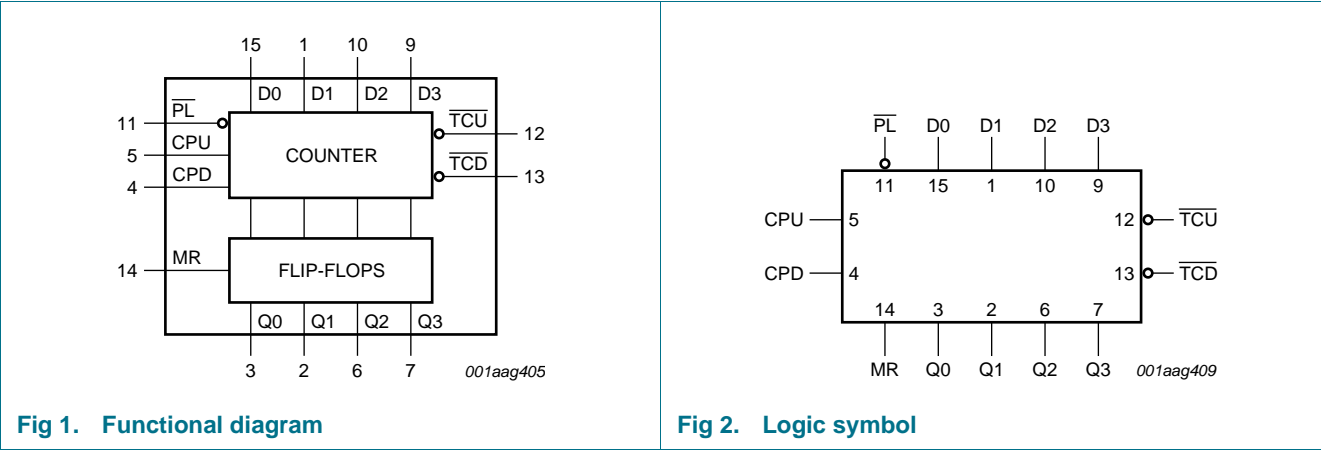


Fig 1. Functional diagram

Fig 2. Logic symbol

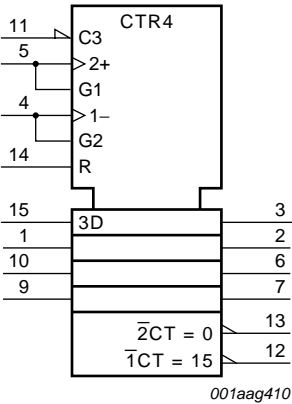


Fig 3. IEC logic symbol

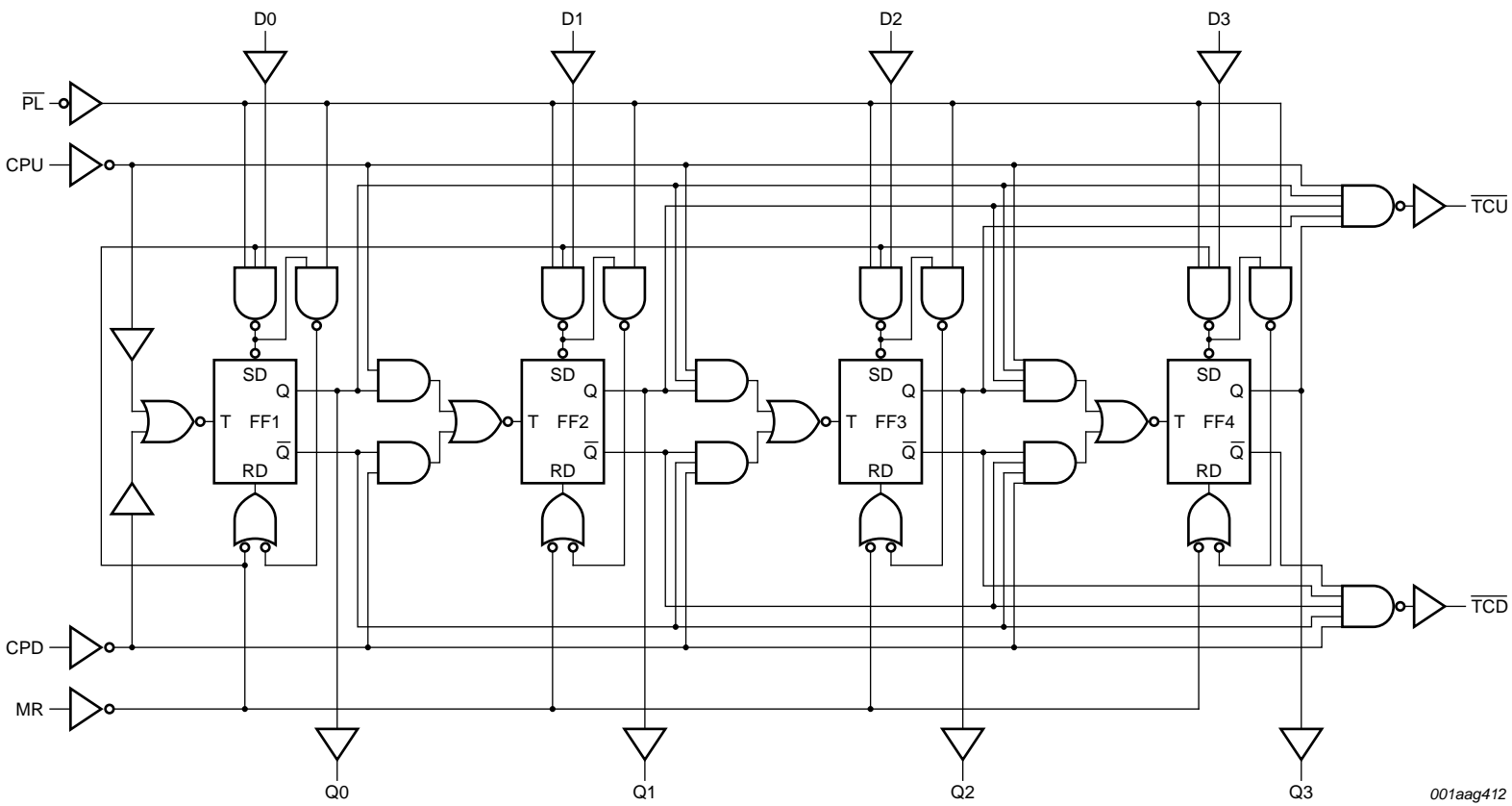
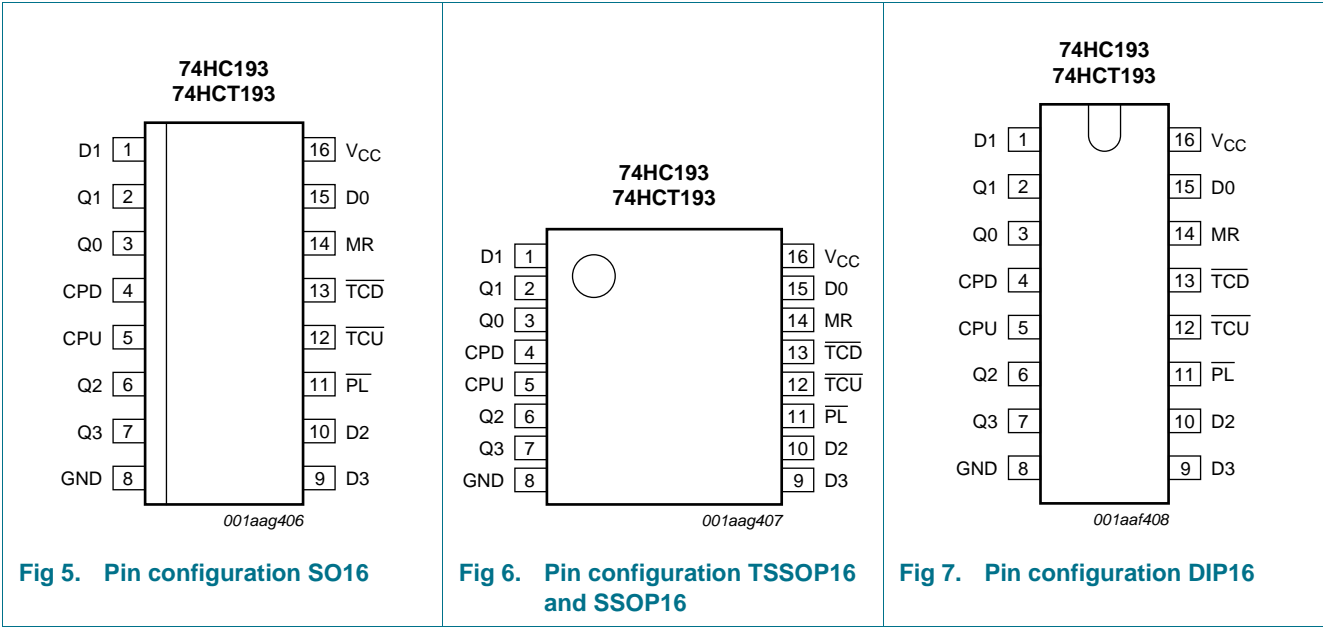


Fig 4. Logic diagram

5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
D0	15	data input 0
D1	1	data input 1
D2	10	data input 2
D3	9	data input 3
Q0	3	flip-flop output 0
Q1	2	flip-flop output 1
Q2	6	flip-flop output 2
Q3	7	flip-flop output 3
CPD	4	count down clock input <sup>[1]</sup>
CPU	5	count up clock input <sup>[1]</sup>
GND	8	ground (0 V)
PL	11	asynchronous parallel load input (active LOW)
TCU	12	terminal count up (carry) output (active LOW)
TCD	13	terminal count down (borrow) output (active LOW)
MR	14	asynchronous master reset input (active HIGH)
VCC	16	supply voltage

[1] LOW-to-HIGH, edge triggered.

## 6. Functional description

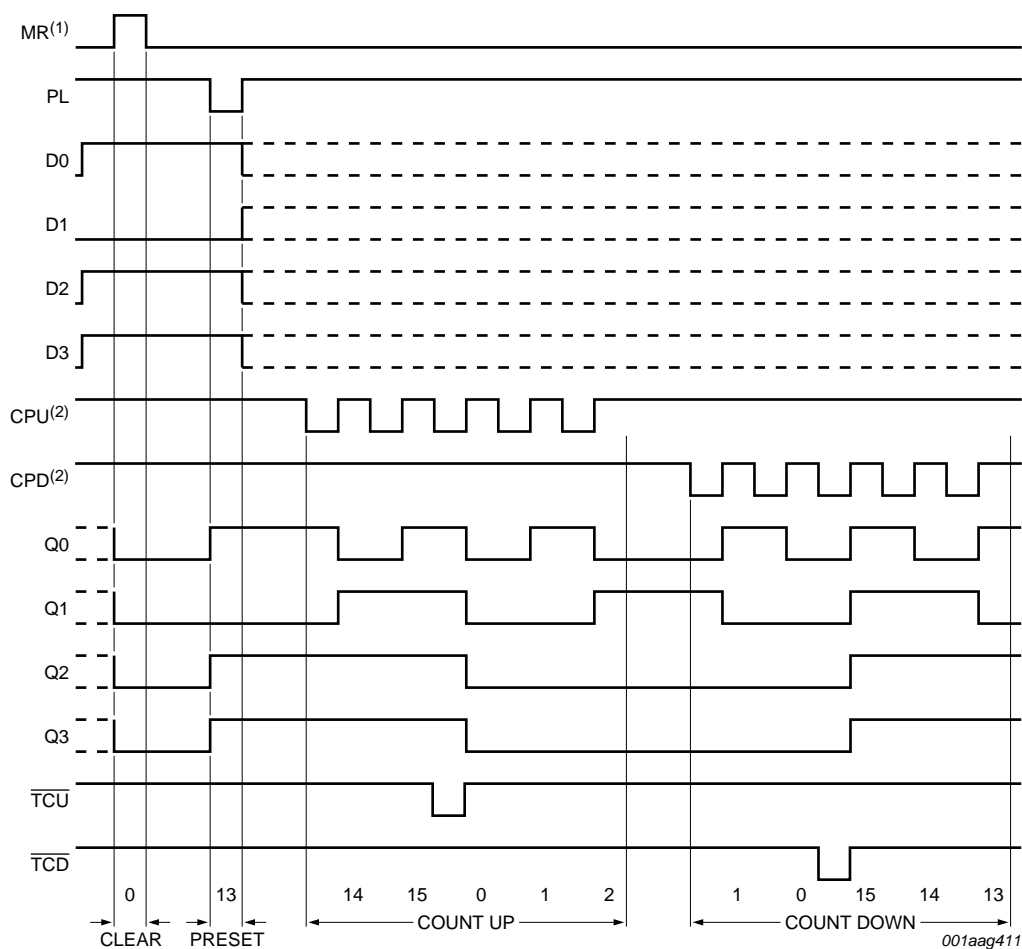
Table 3. Function table<sup>[1]</sup>

Operating mode	Inputs								Outputs					
	MR	$\overline{\text{PL}}$	CPU	CPD	D0	D1	D2	D3	Q0	Q1	Q2	Q3	$\overline{\text{TCU}}$	$\overline{\text{TCD}}$
Reset (clear)	H	X	X	L	X	X	X	X	L	L	L	L	H	L
	H	X	X	H	X	X	X	X	L	L	L	L	H	H
Parallel load	L	L	X	L	L	L	L	L	L	L	L	L	H	L
	L	L	X	H	L	L	L	L	L	L	L	L	H	H
	L	L	L	X	H	H	H	H	H	H	H	H	L	H
	L	L	H	X	H	H	H	H	H	H	H	H	H	H
Count up	L	H	$\uparrow$	H	X	X	X	X	count up				H <sup>[2]</sup>	H
Count down	L	H	H	$\uparrow$	X	X	X	X	count down				H	H <sup>[3]</sup>

- [1] H = HIGH voltage level  
 L = LOW voltage level  
 X = don't care  
 $\uparrow$  = LOW-to-HIGH clock transition.

- [2]  $\overline{\text{TCU}}$  = CPU at terminal count up (HHHH)

- [3]  $\overline{\text{TCD}}$  = CPD at terminal count down (LLLL).



- (1) Clear overrides load, data and count inputs.  
 (2) When counting up, the count down clock input (CPD) must be HIGH, when counting down the count up clock input (CPU) must be HIGH.

#### Sequence

Clear (reset outputs to zero);

load (preset) to binary thirteen;

count up to fourteen, fifteen, terminal count up, zero, one and two;

count down to one, zero, terminal count down, fifteen, fourteen and thirteen.

**Fig 8. Typical clear, load and count sequence**

## 7. Limiting values

**Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+7.0	V
$I_{IK}$	input clamping current	$V_I < -0.5\text{ V}$ or $V_I > V_{CC} + 0.5\text{ V}$	[1] -	$\pm 20$	mA
$I_{OK}$	output clamping current	$V_O < -0.5\text{ V}$ or $V_O > V_{CC} + 0.5\text{ V}$	[1] -	$\pm 20$	mA
$I_O$	output current	$V_O = -0.5\text{ V}$ to $V_{CC} + 0.5\text{ V}$	-	$\pm 25$	mA
$I_{CC}$	supply current		-	50	mA
$I_{GND}$	ground current		-	-50	mA
$T_{stg}$	storage temperature		-65	+150	°C
$P_{tot}$	total power dissipation	DIP16 package	[2] -	750	mW
		SO16 package	[2] -	500	mW
		SSOP16 package	[2] -	500	mW
		TSSOP16 package	[2] -	500	mW

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] For DIP16 packages: above 70 °C the value of  $P_{tot}$  derates linearly at 12 mW/K.

For SO16 packages: above 70 °C the value of  $P_{tot}$  derates linearly at 8 mW/K.

For SSOP16 and TSSOP16 packages: above 60 °C the value of  $P_{tot}$  derates linearly at 5.5 mW/K.

## 8. Recommended operating conditions

**Table 5. Recommended operating conditions**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
74HC193						
V <sub>CC</sub>	supply voltage		2.0	5.0	6.0	V
V <sub>I</sub>	input voltage		0	-	V <sub>CC</sub>	V
V <sub>O</sub>	output voltage		0	-	V <sub>CC</sub>	V
T <sub>amb</sub>	ambient temperature		−40	+25	+125	°C
Δt/ΔV	input transition rise and fall rate	V <sub>CC</sub> = 2.0 V	-	-	625	ns/V
		V <sub>CC</sub> = 4.5 V	-	1.67	139	ns/V
		V <sub>CC</sub> = 6.0 V	-	-	83	ns/V
74HCT193						
V <sub>CC</sub>	supply voltage		4.5	5.0	5.5	V
V <sub>I</sub>	input voltage		0	-	V <sub>CC</sub>	V
V <sub>O</sub>	output voltage		0	-	V <sub>CC</sub>	V
T <sub>amb</sub>	ambient temperature		−40	+25	+125	°C
Δt/ΔV	input transition rise and fall rate	V <sub>CC</sub> = 4.5 V	-	1.67	139	ns/V



## 9. Static characteristics

**Table 6. Static characteristics type 74HC193**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>T<sub>amb</sub> = 25 °C</b>						
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 2.0 V	1.5	1.2	-	V
		V <sub>CC</sub> = 4.5 V	3.15	2.4	-	V
		V <sub>CC</sub> = 6.0 V	4.2	3.2	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 2.0 V	-	0.8	0.5	V
		V <sub>CC</sub> = 4.5 V	-	2.1	1.35	V
		V <sub>CC</sub> = 6.0 V	-	2.8	1.8	V
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>	-	-	-	
		I <sub>O</sub> = -20 µA; V <sub>CC</sub> = 2.0 V	1.9	2.0	-	V
		I <sub>O</sub> = -20 µA; V <sub>CC</sub> = 4.5 V	4.4	4.5	-	V
		I <sub>O</sub> = -20 µA; V <sub>CC</sub> = 6.0 V	5.9	6.0	-	V
		I <sub>O</sub> = -4.0 mA; V <sub>CC</sub> = 4.5 V	3.98	4.32	-	V
		I <sub>O</sub> = -5.2 mA; V <sub>CC</sub> = 6.0 V	5.48	5.81	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>	-	-	-	
		I <sub>O</sub> = 20 µA; V <sub>CC</sub> = 2.0 V	-	0	0.1	V
		I <sub>O</sub> = 20 µA; V <sub>CC</sub> = 4.5 V	-	0	0.1	V
		I <sub>O</sub> = 20 µA; V <sub>CC</sub> = 6.0 V	-	0	0.1	V
		I <sub>O</sub> = 4.0 mA; V <sub>CC</sub> = 4.5 V	-	0.15	0.26	V
		I <sub>O</sub> = 5.2 mA; V <sub>CC</sub> = 6.0 V	-	0.16	0.26	V
I <sub>I</sub>	input leakage current	V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>CC</sub> = 6.0 V	-	-	±0.1	µA
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 6.0 V	-	-	8.0	µA
C <sub>i</sub>	input capacitance		-	3.5	-	pF
<b>T<sub>amb</sub> = -40 °C to +85 °C</b>						
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 2.0 V	1.5	-	-	V
		V <sub>CC</sub> = 4.5 V	3.15	-	-	V
		V <sub>CC</sub> = 6.0 V	4.2	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 2.0 V	-	-	0.5	V
		V <sub>CC</sub> = 4.5 V	-	-	1.35	V
		V <sub>CC</sub> = 6.0 V	-	-	1.8	V
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>	-	-	-	
		I <sub>O</sub> = -20 µA; V <sub>CC</sub> = 2.0 V	1.9	-	-	V
		I <sub>O</sub> = -20 µA; V <sub>CC</sub> = 4.5 V	4.4	-	-	V
		I <sub>O</sub> = -20 µA; V <sub>CC</sub> = 6.0 V	5.9	-	-	V
		I <sub>O</sub> = -4.0 mA; V <sub>CC</sub> = 4.5 V	3.84	-	-	V
		I <sub>O</sub> = -5.2 mA; V <sub>CC</sub> = 6.0 V	5.34	-	-	V

**Table 6.** Static characteristics type 74HC193 ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>				
		I <sub>O</sub> = 20 µA; V <sub>CC</sub> = 2.0 V	-	-	0.1	V
		I <sub>O</sub> = 20 µA; V <sub>CC</sub> = 4.5 V	-	-	0.1	V
		I <sub>O</sub> = 20 µA; V <sub>CC</sub> = 6.0 V	-	-	0.1	V
		I <sub>O</sub> = 4.0 mA; V <sub>CC</sub> = 4.5 V	-	-	0.33	V
		I <sub>O</sub> = 5.2 mA; V <sub>CC</sub> = 6.0 V	-	-	0.33	V
I <sub>I</sub>	input leakage current	V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>CC</sub> = 6.0 V	-	-	±1.0	µA
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 6.0 V	-	-	80	µA
T <sub>amb</sub> = -40 °C to +125 °C						
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 2.0 V	1.5	-	-	V
		V <sub>CC</sub> = 4.5 V	3.15	-	-	V
		V <sub>CC</sub> = 6.0 V	4.2	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 2.0 V	-	-	0.5	V
		V <sub>CC</sub> = 4.5 V	-	-	1.35	V
		V <sub>CC</sub> = 6.0 V	-	-	1.8	V
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>				
		I <sub>O</sub> = -20 µA; V <sub>CC</sub> = 2.0 V	1.9	-	-	V
		I <sub>O</sub> = -20 µA; V <sub>CC</sub> = 4.5 V	4.4	-	-	V
		I <sub>O</sub> = -20 µA; V <sub>CC</sub> = 6.0 V	5.9	-	-	V
		I <sub>O</sub> = -4.0 mA; V <sub>CC</sub> = 4.5 V	3.7	-	-	V
		I <sub>O</sub> = -5.2 mA; V <sub>CC</sub> = 6.0 V	5.2	-	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>				
		I <sub>O</sub> = 20 µA; V <sub>CC</sub> = 2.0 V	-	-	0.1	V
		I <sub>O</sub> = 20 µA; V <sub>CC</sub> = 4.5 V	-	-	0.1	V
		I <sub>O</sub> = 20 µA; V <sub>CC</sub> = 6.0 V	-	-	0.1	V
		I <sub>O</sub> = 4.0 mA; V <sub>CC</sub> = 4.5 V	-	-	0.4	V
		I <sub>O</sub> = 5.2 mA; V <sub>CC</sub> = 6.0 V	-	-	0.4	V
I <sub>I</sub>	input leakage current	V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>CC</sub> = 6.0 V	-	-	±1.0	µA
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 6.0 V	-	-	160	µA

**Table 7.** Static characteristics type 74HCT193

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
T <sub>amb</sub> = 25 °C						
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2.0	1.6	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	-	1.2	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; V <sub>CC</sub> = 4.5 V				
		I <sub>O</sub> = -20 µA	4.4	4.5	-	V
		I <sub>O</sub> = -4.0 mA	3.98	4.32	-	V

**Table 7.** Static characteristics type 74HCT193 ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; V <sub>CC</sub> = 4.5 V				
		I <sub>O</sub> = 20 μA	-	0	0.1	V
		I <sub>O</sub> = 4.0 mA	-	0.15	0.26	V
I <sub>I</sub>	input leakage current	V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>CC</sub> = 5.5 V	-	-	±0.1	μA
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 5.5 V	-	-	8.0	μA
ΔI <sub>CC</sub>	additional supply current	per input pin; V <sub>I</sub> = V <sub>CC</sub> – 2.1 V and other inputs at V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 4.5 V to 5.5 V				
		pin Dn	-	35	126	μA
		pins CPU, CPD	-	140	504	μA
		pin $\overline{\text{PL}}$	-	65	234	μA
		pin MR	-	105	378	μA
C <sub>i</sub>	input capacitance		-	3.5	-	pF
T <sub>amb</sub> = –40 °C to +85 °C						
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	-	-	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; V <sub>CC</sub> = 4.5 V				
		I <sub>O</sub> = –20 μA	4.4	-	-	V
		I <sub>O</sub> = –4.0 mA	3.84	-	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; V <sub>CC</sub> = 4.5 V				
		I <sub>O</sub> = 20 μA	-	-	0.1	V
		I <sub>O</sub> = 4.0 mA	-	-	0.33	V
I <sub>I</sub>	input leakage current	V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>CC</sub> = 5.5 V	-	-	±1.0	μA
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 5.5 V	-	-	80	μA
ΔI <sub>CC</sub>	additional supply current	per input pin; V <sub>I</sub> = V <sub>CC</sub> – 2.1 V and other inputs at V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 4.5 V to 5.5 V				
		pin Dn	-	-	157.5	μA
		pins CPU, CPD	-	-	630	μA
		pin $\overline{\text{PL}}$	-	-	292.5	μA
		pin MR	-	-	472.5	μA
T <sub>amb</sub> = –40 °C to +125 °C						
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	-	-	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; V <sub>CC</sub> = 4.5 V				
		I <sub>O</sub> = –20 μA	4.4	-	-	V
		I <sub>O</sub> = –4.0 mA	3.7	-	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; V <sub>CC</sub> = 4.5 V				
		I <sub>O</sub> = 20 μA	-	-	0.1	V
		I <sub>O</sub> = 4.0 mA	-	-	0.4	V

**Table 7.** Static characteristics type 74HCT193 ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$I_I$	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5$ V	-	-	$\pm 1.0$	$\mu A$
$I_{CC}$	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5$ V	-	-	160	$\mu A$
$\Delta I_{CC}$	additional supply current	per input pin; $V_I = V_{CC} - 2.1$ V and other inputs at $V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 4.5$ V to 5.5 V				
		pin Dn	-	-	171.5	$\mu A$
		pins CPU, CPD	-	-	686	$\mu A$
		pin $\overline{PL}$	-	-	318.5	$\mu A$
		pin MR	-	-	514.5	$\mu A$

## 10. Dynamic characteristics

Table 8. Dynamic characteristics type 74HC193

Symbol	Parameter	Conditions	25 °C			–40 °C to +85 °C		–40 °C to +125 °C		Unit
			Min	Typ	Max	Min	Max	Min	Max	
$t_{pd}$	propagation delay	CPU, CPD to Qn; see <a href="#">Figure 9</a>	[1]			-				
		$V_{CC} = 2.0\text{ V}$	-	63	215	-	270	-	325	ns
		$V_{CC} = 4.5\text{ V}$	-	23	43	-	54	-	65	ns
		$V_{CC} = 6.0\text{ V}$	-	18	37	-	46	-	55	ns
		CPU to TCU; see <a href="#">Figure 10</a>								
		$V_{CC} = 2.0\text{ V}$	-	39	125	-	155	-	190	ns
		$V_{CC} = 4.5\text{ V}$	-	14	25	-	31	-	38	ns
		$V_{CC} = 6.0\text{ V}$	-	11	21	-	26	-	32	ns
		CPD to TCD; see <a href="#">Figure 10</a>								
		$V_{CC} = 2.0\text{ V}$	-	39	125	-	155	-	190	ns
		$V_{CC} = 4.5\text{ V}$	-	14	25	-	31	-	38	ns
		$V_{CC} = 6.0\text{ V}$	-	11	21	-	26	-	32	ns
		PL to Qn; see <a href="#">Figure 11</a>								
		$V_{CC} = 2.0\text{ V}$	-	69	220	-	275	-	330	ns
		$V_{CC} = 4.5\text{ V}$	-	25	44	-	55	-	66	ns
		$V_{CC} = 6.0\text{ V}$	-	20	37	-	47	-	56	ns
		MR to Qn; see <a href="#">Figure 12</a>								
		$V_{CC} = 2.0\text{ V}$	-	58	200	-	250	-	300	ns
		$V_{CC} = 4.5\text{ V}$	-	21	40	-	50	-	60	ns
		$V_{CC} = 6.0\text{ V}$	-	17	34	-	43	-	51	ns
		Dn to Qn; see <a href="#">Figure 11</a>								
		$V_{CC} = 2.0\text{ V}$	-	69	210	-	265	-	315	ns
		$V_{CC} = 4.5\text{ V}$	-	25	42	-	53	-	63	ns
		$V_{CC} = 6.0\text{ V}$	-	20	36	-	45	-	54	ns
		PL to TCU, PL to TCD; see <a href="#">Figure 14</a>								
		$V_{CC} = 2.0\text{ V}$	-	80	290	-	365	-	435	ns
		$V_{CC} = 4.5\text{ V}$	-	29	58	-	73	-	87	ns
		$V_{CC} = 6.0\text{ V}$	-	23	49	-	62	-	74	ns
		MR to TCU, MR to TCD; see <a href="#">Figure 14</a>								
		$V_{CC} = 2.0\text{ V}$	-	74	285	-	355	-	430	ns
		$V_{CC} = 4.5\text{ V}$	-	27	57	-	71	-	86	ns
		$V_{CC} = 6.0\text{ V}$	-	22	48	-	60	-	73	ns

Table 8. Dynamic characteristics type 74HC193 ...continued

Symbol	Parameter	Conditions	25 °C			−40 °C to +85 °C		−40 °C to +125 °C		Unit
			Min	Typ	Max	Min	Max	Min	Max	
$t_{pd}$	propagation delay	Dn to $\overline{TCU}$ , Dn to TCD; see <a href="#">Figure 14</a>								
		$V_{CC} = 2.0\text{ V}$	-	80	290	-	365	-	435	ns
		$V_{CC} = 4.5\text{ V}$	-	29	58	-	73	-	87	ns
		$V_{CC} = 6.0\text{ V}$	-	23	49	-	62	-	74	ns
$t_{THL}$	HIGH to LOW output transition time	see <a href="#">Figure 12</a>								
		$V_{CC} = 2.0\text{ V}$	-	19	75	-	95	-	110	ns
		$V_{CC} = 4.5\text{ V}$	-	7	15	-	19	-	22	ns
		$V_{CC} = 6.0\text{ V}$	-	6	13	-	16	-	19	ns
$t_{TLH}$	LOW to HIGH output transition time	see <a href="#">Figure 12</a>								
		$V_{CC} = 2.0\text{ V}$	-	19	75	-	95	-	110	ns
		$V_{CC} = 4.5\text{ V}$	-	7	15	-	19	-	22	ns
		$V_{CC} = 6.0\text{ V}$	-	6	13	-	16	-	19	ns
$t_W$	pulse width	CPU, CPD (HIGH or LOW); see <a href="#">Figure 9</a>								
		$V_{CC} = 2.0\text{ V}$	100	22	-	125	-	150	-	ns
		$V_{CC} = 4.5\text{ V}$	20	8	-	25	-	30	-	ns
		$V_{CC} = 6.0\text{ V}$	17	6	-	21	-	26	-	ns
		MR (HIGH); see <a href="#">Figure 12</a>								
		$V_{CC} = 2.0\text{ V}$	100	25	-	125	-	150	-	ns
		$V_{CC} = 4.5\text{ V}$	20	9	-	25	-	30	-	ns
		$V_{CC} = 6.0\text{ V}$	17	7	-	21	-	26	-	ns
		$\overline{PL}$ (LOW); see <a href="#">Figure 11</a>								
		$V_{CC} = 2.0\text{ V}$	100	19	-	125	-	150	-	ns
		$V_{CC} = 4.5\text{ V}$	20	7	-	25	-	30	-	ns
		$V_{CC} = 6.0\text{ V}$	17	6	-	21	-	26	-	ns
$t_{rec}$	recovery time	$\overline{PL}$ to CPU, CPD; see <a href="#">Figure 11</a>								
		$V_{CC} = 2.0\text{ V}$	50	8	-	65	-	75	-	ns
		$V_{CC} = 4.5\text{ V}$	10	3	-	13	-	15	-	ns
		$V_{CC} = 6.0\text{ V}$	9	2	-	11	-	13	-	ns
		MR to CPU, CPD; see <a href="#">Figure 12</a>								
		$V_{CC} = 2.0\text{ V}$	50	0	-	65	-	75	-	ns
		$V_{CC} = 4.5\text{ V}$	10	0	-	13	-	15	-	ns
		$V_{CC} = 6.0\text{ V}$	9	0	-	11	-	13	-	ns

Table 8. Dynamic characteristics type 74HC193 ...continued

Symbol	Parameter	Conditions	25 °C			–40 °C to +85 °C		–40 °C to +125 °C		Unit
			Min	Typ	Max	Min	Max	Min	Max	
$t_{su}$	set-up time	Dn to $\overline{PL}$ ; see Figure 13; note: CPU = CPD = HIGH								
		$V_{CC} = 2.0\text{ V}$	80	22	-	100	-	120	-	ns
		$V_{CC} = 4.5\text{ V}$	16	8	-	20	-	24	-	ns
		$V_{CC} = 6.0\text{ V}$	14	6	-	17	-	20	-	ns
$t_h$	hold time	Dn to $\overline{PL}$ ; see Figure 13								
		$V_{CC} = 2.0\text{ V}$	0	–14	-	0	-	0	-	ns
		$V_{CC} = 4.5\text{ V}$	0	–5	-	0	-	0	-	ns
		$V_{CC} = 6.0\text{ V}$	0	–4	-	0	-	0	-	ns
		CPU to CPD, CPD to CPU; see Figure 15								
		$V_{CC} = 2.0\text{ V}$	80	22	-	100	-	120	-	ns
		$V_{CC} = 4.5\text{ V}$	16	8	-	20	-	24	-	ns
		$V_{CC} = 6.0\text{ V}$	8	6	-	17	-	20	-	ns
$f_{max}$	maximum frequency	CPU, CPD; see Figure 9								
		$V_{CC} = 2.0\text{ V}$	4.0	13.5	-	3.2	-	2.6	-	MHz
		$V_{CC} = 4.5\text{ V}$	20	41	-	16	-	13	-	MHz
		$V_{CC} = 6.0\text{ V}$	24	49	-	19	-	15	-	MHz
$C_{PD}$	power dissipation capacitance	$V_I = \text{GND to } V_{CC}$ ; [2] $V_{CC} = 5\text{ V}$ ; $f_i = 1\text{ MHz}$	-	24	-	-	-	-	-	pF

[1]  $t_{pd}$  is the same as  $t_{PHL}$  and  $t_{PLH}$ .

[2]  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu\text{W}$ ):

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o) \text{ where:}$$

$f_i$  = input frequency in MHz;

$f_o$  = output frequency in MHz;

$C_L$  = output load capacitance in pF;

$V_{CC}$  = supply voltage in V;

$N$  = number of inputs switching;

$\sum (C_L \times V_{CC}^2 \times f_o)$  = sum of outputs.

Table 9. Dynamic characteristics type 74HCT193

Symbol	Parameter	Conditions	25 °C			–40 °C to +85 °C		–40 °C to +125 °C		Unit
			Min	Typ	Max	Min	Max	Min	Max	
t <sub>pd</sub>	propagation delay	CPU, CPD to Qn; see <a href="#">Figure 9</a> <sup>[1]</sup>								
		V <sub>CC</sub> = 4.5 V	-	23	43	-	54	-	65	ns
		CPU to $\overline{\text{TCU}}$ ; see <a href="#">Figure 10</a>								
		V <sub>CC</sub> = 4.5 V	-	15	27	-	34	-	41	ns
		CPD to $\overline{\text{TCD}}$ ; see <a href="#">Figure 10</a>								
		V <sub>CC</sub> = 4.5 V	-	15	27	-	34	-	41	ns
		$\overline{\text{PL}}$ to Qn; see <a href="#">Figure 11</a>								
		V <sub>CC</sub> = 4.5 V	-	26	46	-	58	-	69	ns
		MR to Qn; see <a href="#">Figure 12</a>								
		V <sub>CC</sub> = 4.5 V	-	22	40	-	50	-	60	ns
		Dn to Qn; see <a href="#">Figure 11</a>								
		V <sub>CC</sub> = 4.5 V	-	27	46	-	58	-	69	ns
		$\overline{\text{PL}}$ to $\overline{\text{TCU}}$ , $\overline{\text{PL}}$ to $\overline{\text{TCD}}$ ; see <a href="#">Figure 14</a>								
		V <sub>CC</sub> = 4.5 V	-	31	55	-	69	-	83	ns
t <sub>THL</sub>	HIGH to LOW output transition time	MR to $\overline{\text{TCU}}$ , MR to $\overline{\text{TCD}}$ ; see <a href="#">Figure 14</a>								
		V <sub>CC</sub> = 4.5 V	-	29	55	-	69	-	83	ns
t <sub>TLH</sub>	LOW to HIGH output transition time	Dn to $\overline{\text{TCU}}$ , Dn to $\overline{\text{TCD}}$ ; see <a href="#">Figure 14</a>								
		V <sub>CC</sub> = 4.5 V	-	32	58	-	73	-	87	ns
t <sub>w</sub>	pulse width	see <a href="#">Figure 12</a>								
		V <sub>CC</sub> = 4.5 V	-	7	15	-	19	-	22	ns
		see <a href="#">Figure 12</a>								
		V <sub>CC</sub> = 4.5 V	-	7	15	-	19	-	22	ns
		CPU, CPD (HIGH or LOW); see <a href="#">Figure 9</a>								
t <sub>w</sub>	pulse width	V <sub>CC</sub> = 4.5 V	25	11	-	31	-	38	-	ns
		MR (HIGH); see <a href="#">Figure 12</a>								
		V <sub>CC</sub> = 4.5 V	20	7	-	25	-	30	-	ns
		$\overline{\text{PL}}$ (LOW); see <a href="#">Figure 11</a>								
		V <sub>CC</sub> = 4.5 V	20	8	-	25	-	30	-	ns



Table 9. Dynamic characteristics type 74HCT193 ...continued

Symbol	Parameter	Conditions	25 °C			–40 °C to +85 °C		–40 °C to +125 °C		Unit
			Min	Typ	Max	Min	Max	Min	Max	
$t_{\text{rec}}$	recovery time	$\overline{\text{PL}}$ to CPU, CPD; see <a href="#">Figure 11</a>								
		$V_{\text{CC}} = 4.5 \text{ V}$	10	2	-	13	-	15	-	ns
		MR to CPU, CPD; see <a href="#">Figure 12</a>								
		$V_{\text{CC}} = 4.5 \text{ V}$	10	0	-	13	-	15	-	ns
$t_{\text{su}}$	set-up time	Dn to $\overline{\text{PL}}$ ; see <a href="#">Figure 13</a> ; note: CPU = CPD = HIGH								
		$V_{\text{CC}} = 4.5 \text{ V}$	16	8	-	20	-	24	-	ns
$t_{\text{h}}$	hold time	Dn to $\overline{\text{PL}}$ ; see <a href="#">Figure 13</a>								
		$V_{\text{CC}} = 4.5 \text{ V}$	0	–6	-	0	-	0	-	ns
		CPU to CPD, CPD to CPU; see <a href="#">Figure 15</a>								
		$V_{\text{CC}} = 4.5 \text{ V}$	16	7	-	20	-	24	-	ns
$f_{\text{max}}$	maximum frequency	CPU, CPD; see <a href="#">Figure 9</a>								
		$V_{\text{CC}} = 4.5 \text{ V}$	20	43	-	16	-	13	-	MHz
$C_{\text{PD}}$	power dissipation capacitance	$V_{\text{I}} = \text{GND to } V_{\text{CC}} - [2]$ 1.5 V; $V_{\text{CC}} = 5 \text{ V}$ ; $f_{\text{i}} = 1 \text{ MHz}$	-	26	-	-	-	-	-	pF

[1]  $t_{\text{pd}}$  is the same as  $t_{\text{PHL}}$  and  $t_{\text{PLH}}$ .

[2]  $C_{\text{PD}}$  is used to determine the dynamic power dissipation ( $P_{\text{D}}$  in  $\mu\text{W}$ ):

$$P_{\text{D}} = C_{\text{PD}} \times V_{\text{CC}}^2 \times f_{\text{i}} \times N + \sum (C_{\text{L}} \times V_{\text{CC}}^2 \times f_{\text{o}}) \text{ where:}$$

$f_{\text{i}}$  = input frequency in MHz;

$f_{\text{o}}$  = output frequency in MHz;

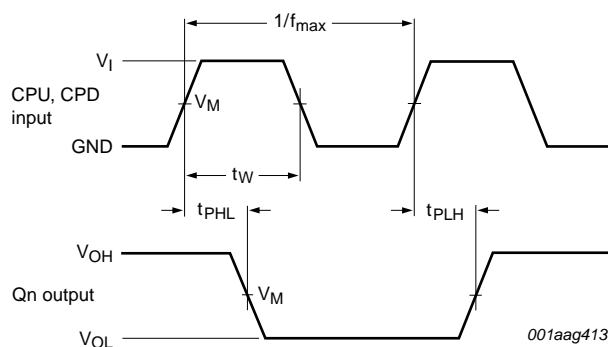
$C_{\text{L}}$  = output load capacitance in pF;

$V_{\text{CC}}$  = supply voltage in V;

$N$  = number of inputs switching;

$\sum (C_{\text{L}} \times V_{\text{CC}}^2 \times f_{\text{o}}) = \text{sum of outputs.}$

## 11. Waveforms

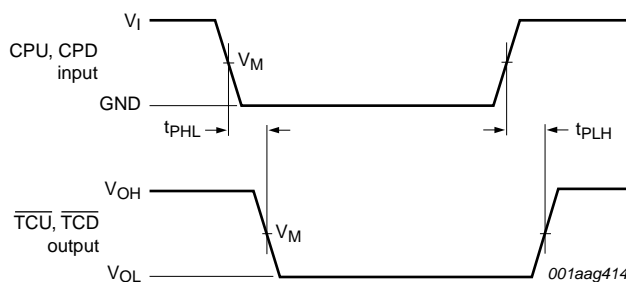


Measurement points are given in [Table 10](#).

$t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Logic levels  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 9. The clock (CPU, CPD) to output (Qn) propagation delays, the clock pulse width, and the maximum clock pulse frequency**

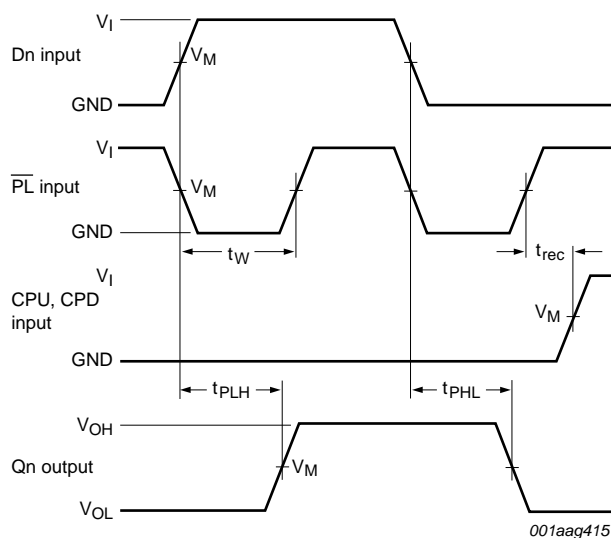


Measurement points are given in [Table 10](#).

$t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Logic levels  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 10. The clock (CPU, CPD) to terminal count output (TCU, TCD) propagation delays**

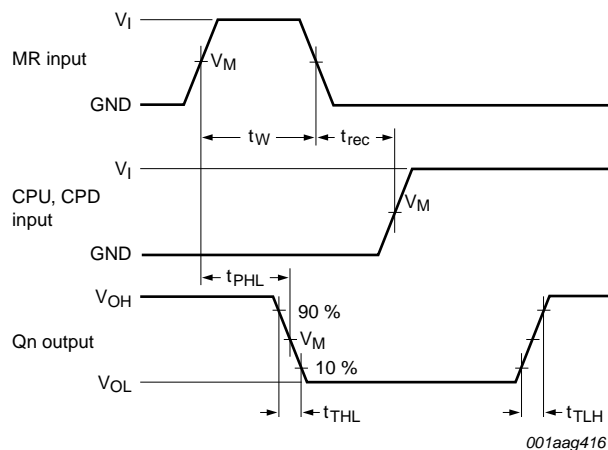


Measurement points are given in [Table 10](#).

$t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Logic levels  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 11. The parallel load input ( $\overline{PL}$ ) and data (Dn) to Qn output propagation delays and  $\overline{PL}$  removal time to clock input (CPU, CPD)**

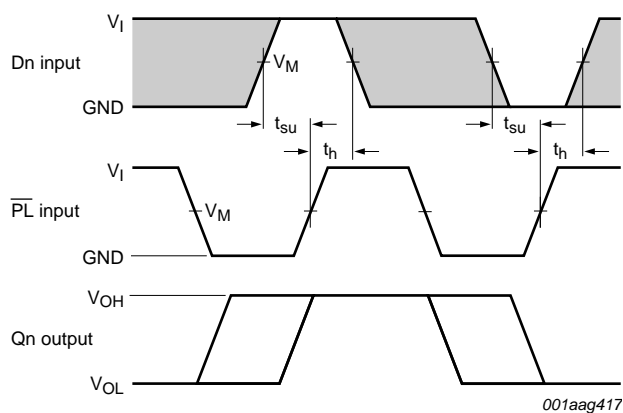


Measurement points are given in [Table 10](#).

$t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Logic levels  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 12. The master reset input (MR) pulse width, MR to Qn propagation delays, MR to CPU, CPD removal time and output transition times**

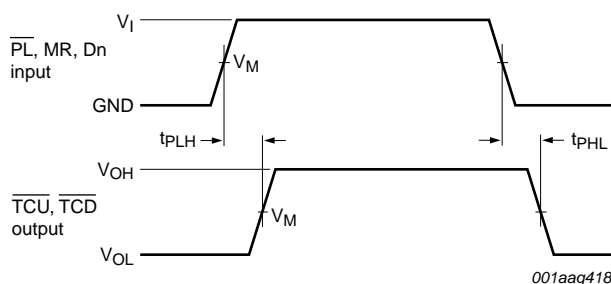


The shaded areas indicate when the input is permitted to change for predictable output performance.

Measurement points are given in [Table 10](#).

Logic levels  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 13. The data input (Dn) to parallel load input ( $\overline{PL}$ ) set-up and hold times**

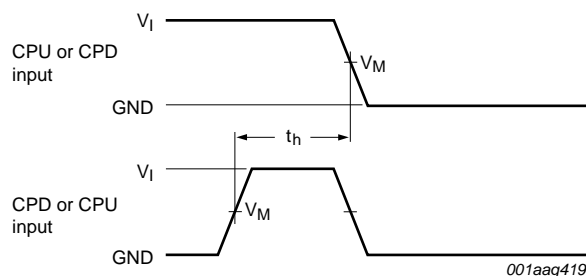


Measurement points are given in [Table 10](#).

$t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Logic levels  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 14. The data input (Dn), parallel load input ( $\overline{PL}$ ) and the master reset input (MR) to the terminal count outputs (TCU, TCD) propagation delays**

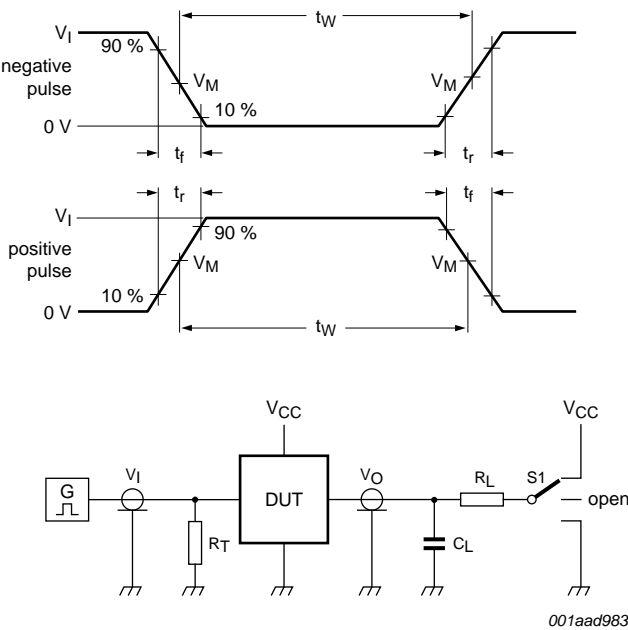


Measurement points are given in [Table 10](#).

**Fig 15. The CPU to CPD or CPD to CPU hold times**

Table 10. Measurement points

Type	Input		Output	
	$V_M$	$V_I$	$V_M$	
74HC193	$0.5 \times V_{CC}$	GND to $V_{CC}$	$0.5 \times V_{CC}$	
74HCT193	1.3 V	GND to 3 V	1.3 V	



Test data is given in [Table 11](#).  
Definitions test circuit:  
 $R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator  
 $C_L$  = Load capacitance including jig and probe capacitance  
 $R_L$  = Load resistor  
 $S1$  = Test selection switch

Fig 16. Load circuitry for measuring switching times

Table 11. Test data

Type	Input		Load		S1 position
	$V_I$	$t_r, t_f$	$C_L$	$R_L$	$t_{PHL}, t_{PLH}$
74HC193	$V_{CC}$	6 ns	15 pF, 50 pF	1 k $\Omega$	open
74HCT193	3 V	6 ns	15 pF, 50 pF	1 k $\Omega$	open

12. Application information

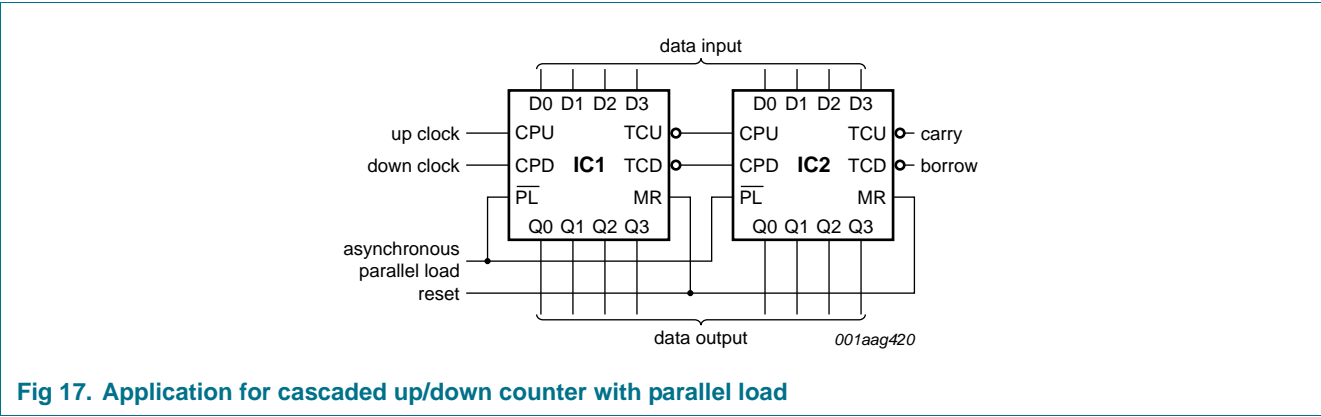


Fig 17. Application for cascaded up/down counter with parallel load

13. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1

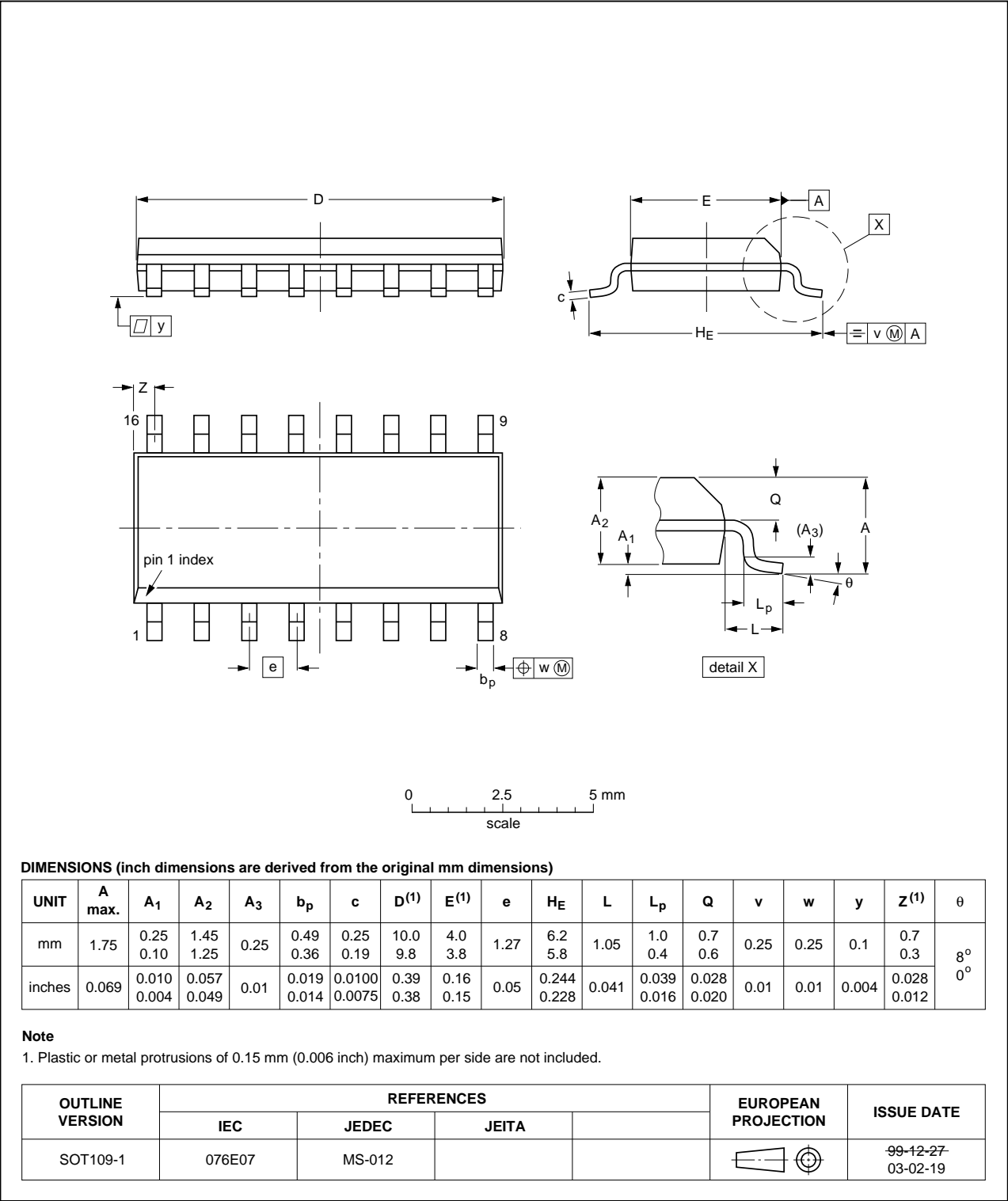


Fig 18. Package outline SOT109-1 (SO16)

SSOP16: plastic shrink small outline package; 16 leads; body width 5.3 mm

SOT338-1

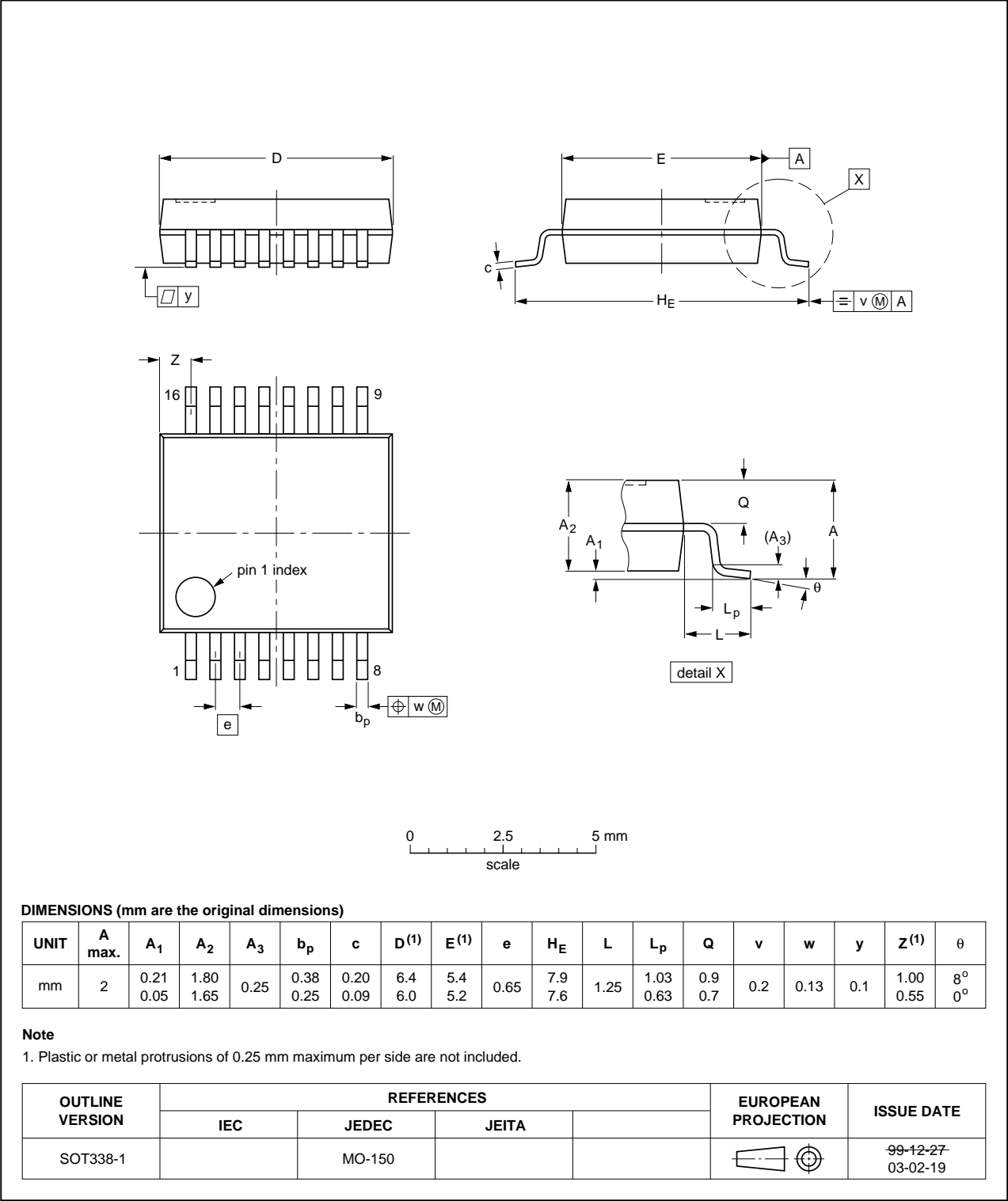
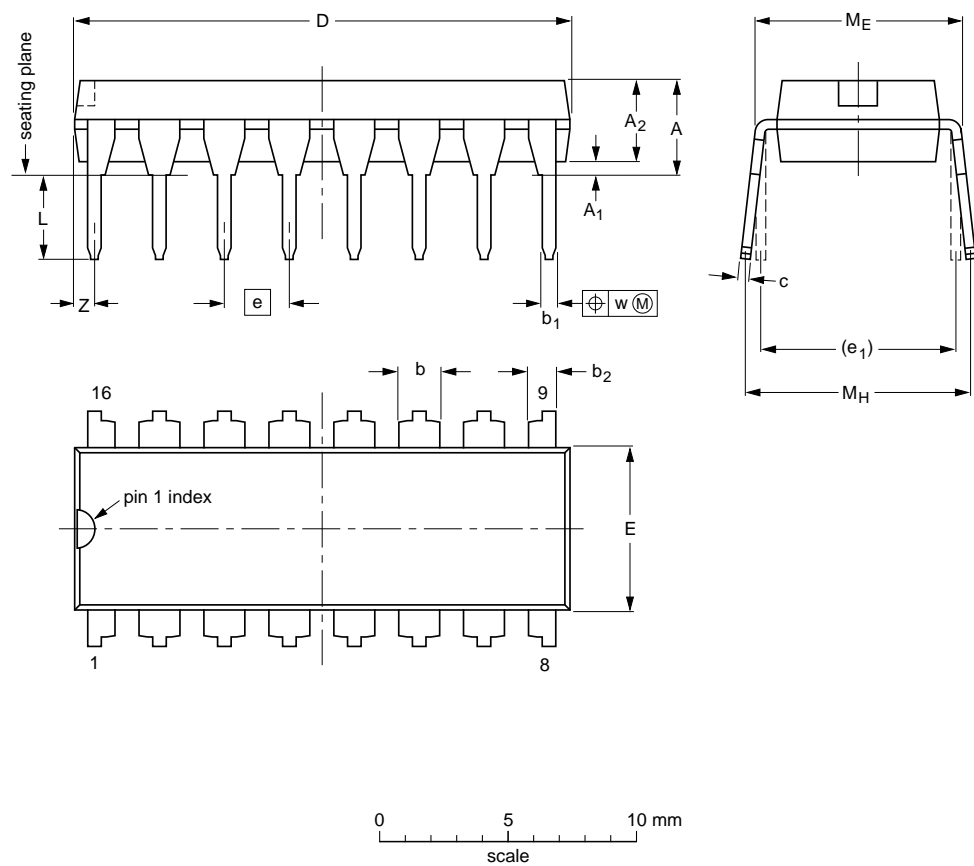


Fig 19. Package outline SOT338-1 (SSOP16)



DIP16: plastic dual in-line package; 16 leads (300 mil)

SOT38-4



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	b <sub>2</sub>	c	D <sup>(1)</sup>	E <sup>(1)</sup>	e	e <sub>1</sub>	L	M <sub>E</sub>	M <sub>H</sub>	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.02	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.1	0.3	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.03

Note

1. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

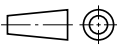
OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT38-4						95-01-14 03-02-13

Fig 20. Package outline SOT38-4 (DIP16)

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1

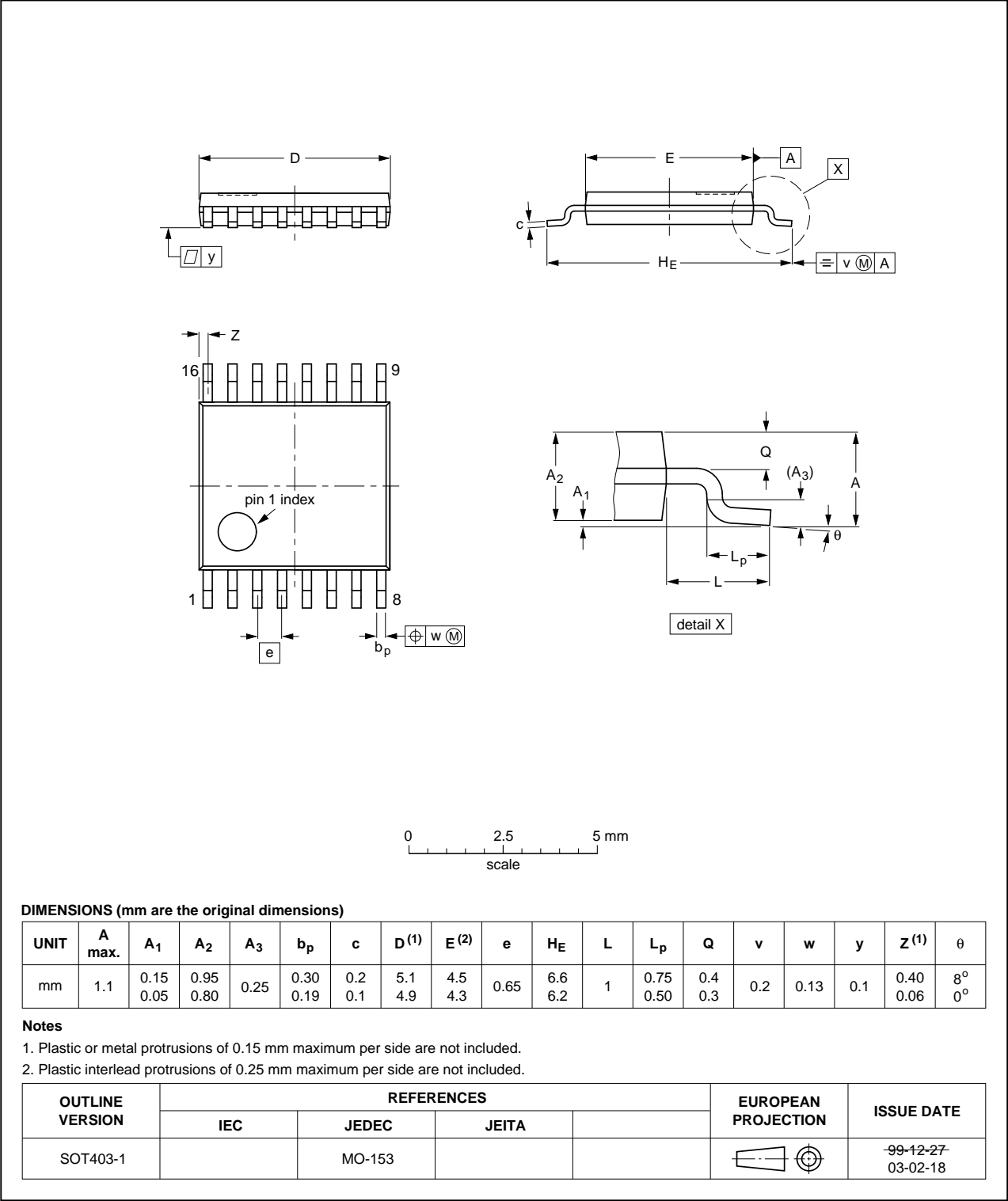


Fig 21. Package outline SOT403-1 (TSSOP16)

## 14. Abbreviations

Table 12. Abbreviations

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
LSTTL	Low-power Schottky Transistor-Transistor Logic
MM	Machine Model
TTL	Transistor-Transistor Logic

## 15. Revision history

Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT193 v.4	20130624	Product data sheet	-	74HC_HCT193 v.3
Modifications:	<ul style="list-style-type: none"><li>• General description updated.</li></ul>			
74HC_HCT193 v.3	20070523	Product data sheet	-	74HC_HCT193_CNV v.2
Modifications:	<ul style="list-style-type: none"><li>• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li><li>• Legal texts have been adapted to the new company name where appropriate.</li><li>• Family specification included</li></ul>			
74HC_HCT193_CNV v.2	19970828	Product specification	-	-

## 16. Legal information

### 16.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

### 16.2 Definitions

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## 18. Contents

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<b>1</b>	<b>General description</b> .....	<b>1</b>
<b>2</b>	<b>Features and benefits</b> .....	<b>1</b>
<b>3</b>	<b>Ordering information</b> .....	<b>2</b>
<b>4</b>	<b>Functional diagram</b> .....	<b>2</b>
<b>5</b>	<b>Pinning information</b> .....	<b>5</b>
5.1	Pinning .....	5
5.2	Pin description .....	5
<b>6</b>	<b>Functional description</b> .....	<b>6</b>
<b>7</b>	<b>Limiting values</b> .....	<b>8</b>
<b>8</b>	<b>Recommended operating conditions</b> .....	<b>8</b>
<b>9</b>	<b>Static characteristics</b> .....	<b>9</b>
<b>10</b>	<b>Dynamic characteristics</b> .....	<b>13</b>
<b>11</b>	<b>Waveforms</b> .....	<b>18</b>
<b>12</b>	<b>Application information</b> .....	<b>22</b>
<b>13</b>	<b>Package outline</b> .....	<b>23</b>
<b>14</b>	<b>Abbreviations</b> .....	<b>27</b>
<b>15</b>	<b>Revision history</b> .....	<b>27</b>
<b>16</b>	<b>Legal information</b> .....	<b>28</b>
16.1	Data sheet status .....	28
16.2	Definitions .....	28
16.3	Disclaimers .....	28
16.4	Trademarks .....	29
<b>17</b>	<b>Contact information</b> .....	<b>29</b>
<b>18</b>	<b>Contents</b> .....	<b>30</b>

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